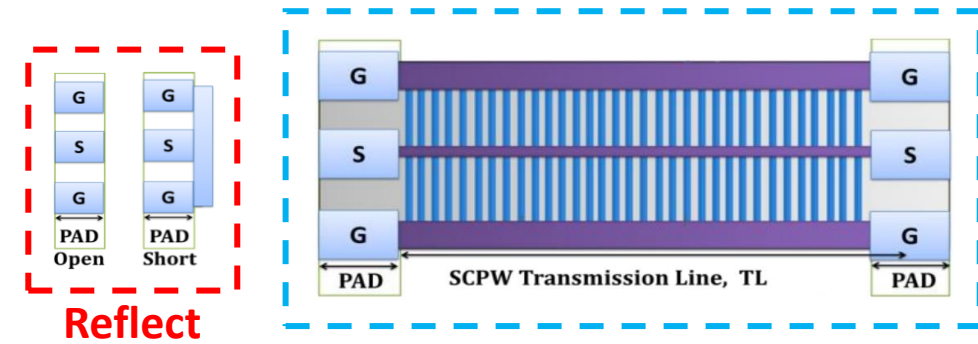
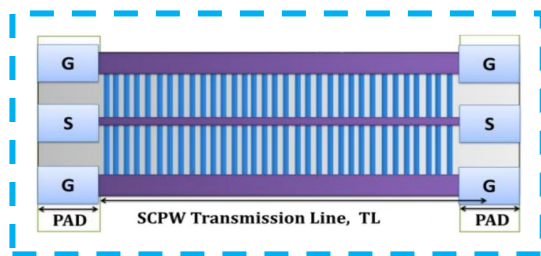
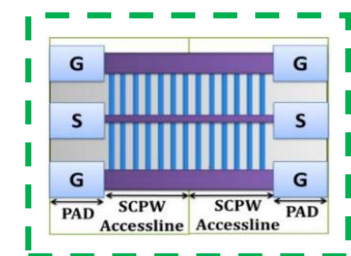


TRL Method

Calibration-kit

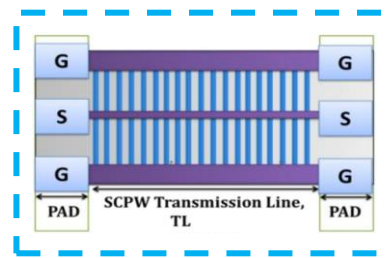


Line1



Line2

$$\begin{aligned} \text{Line1} &\rightarrow \frac{\pi}{1.125} \lambda \rightarrow 160^\circ \\ \text{Line2} &\rightarrow \frac{\pi}{2} \lambda \rightarrow 90^\circ \\ \text{Line3} &\rightarrow \frac{\pi}{9} \lambda \rightarrow 20^\circ \\ \lambda &= \frac{C}{\epsilon_{eff} \times f_{max}} \end{aligned}$$



Line3

Ref: Errikson Lourandakis, On-wafer Microwave measurement and De-embedding, 2016

Mathematical:

$$T_{11} = \frac{b_1}{a_1} = S_{11} + \frac{S_{11}S_{12}^2}{1 - S_{12}^2} \quad T_{21} = T_{12}$$

$$T_{12} = \frac{b_1}{a_2} = \frac{S_{12}^2}{1 - S_{12}^2} \quad T_{11} = T_{22}$$

$$R_{11} = \frac{b_1}{a_1} = S_{11} + \frac{S_{12}^2 \Gamma_L}{1 - S_{22} \Gamma_L}$$

$$L_{11} = \frac{b_1}{a_1} = S_{11} + \frac{S_{22}S_{12}^2 e^{-2\gamma}}{1 - S_{22}^2 e^{-2\gamma}}$$

$$L_{11} = \frac{b_1}{a_1} = \frac{S_{12}^2 e^{-2\gamma}}{1 - S_{22}^2 e^{-2\gamma}}$$

$$Re\{\gamma\}, Im\{\gamma\} > 0$$

$$e^{-2\gamma} = \frac{L_{12}^2 + T_{12}^2 - (T_{11} - L_{11}) \pm \sqrt{[L_{12}^2 + T_{12}^2 - (T_{11} - L_{11})^2]^2 - 4L_{12}^2 T_{12}^2}}{2T_{12}L_{12}}$$

$$S_{22} = \frac{T_{11} - L_{11}}{T_{12} - L_{12}e^{-2\gamma}}$$

$$S_{11} = T_{11} - S_{22}T_{12}$$

$$S_{12}^2 = T_{12}(1 - S_{22}^2)$$

T_{ii} & $T_{ij} \rightarrow$ S-parameters of the Thru Structure

S_{ii} & $S_{ij} \rightarrow$ S-parameters of the pads

L_{ii} & $L_{ij} \rightarrow$ S-parameters of the Line Structures

$R_{ij} \rightarrow$ S-parameters of the Reflect Structures

Ref: Pozar, Microwave Engineering

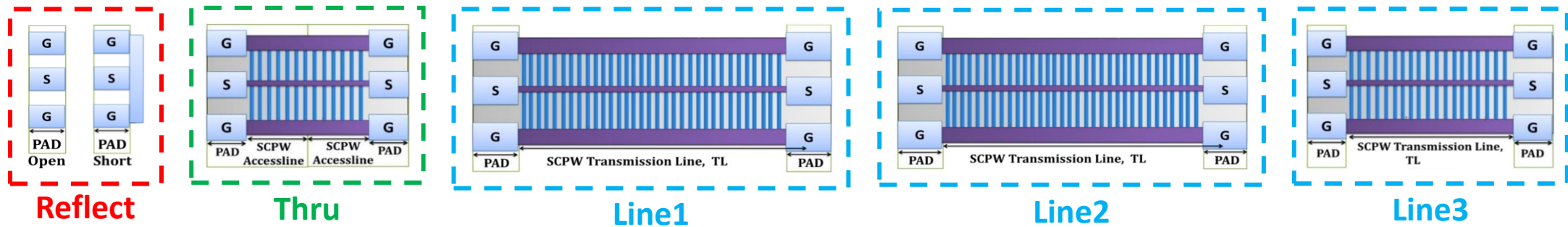
Weakness:

- ❑ High cost due to the number of Cal-kit.
- ❑ The accuracy is decreased due to the number of Cal-kit during the measurement or manufacturing process.
- ❑ Unknown line impedance value, band limited; multiple lines required for wide band.

Ref: G. F. Engen and C. A. Hoer, "Thru-Reflect-Line: An Improved Technique for Calibrating the Dual SixPort Automatic Network Analyzer," *IEEE Trans. Microw. Theory Tech.*, vol. 27, no. 12, pp. 987-993, Dec. 1979.

Multiline TRL Method Options

Frequency Band	Recommended Solution	Line Lengths (mm)	Thru Line Length (mm)	Accuracy
20 to 100 GHz	One Line	0.617331	0.15	
20 to 150 GHz	One Line	0.435763	0.15	
10 to 100 GHz	Two Lines	0.5628, 1.779	0.15	
10 to 200 GHz	Two Lines	0.30271, 1.3537	0.15	



Chip Stackup

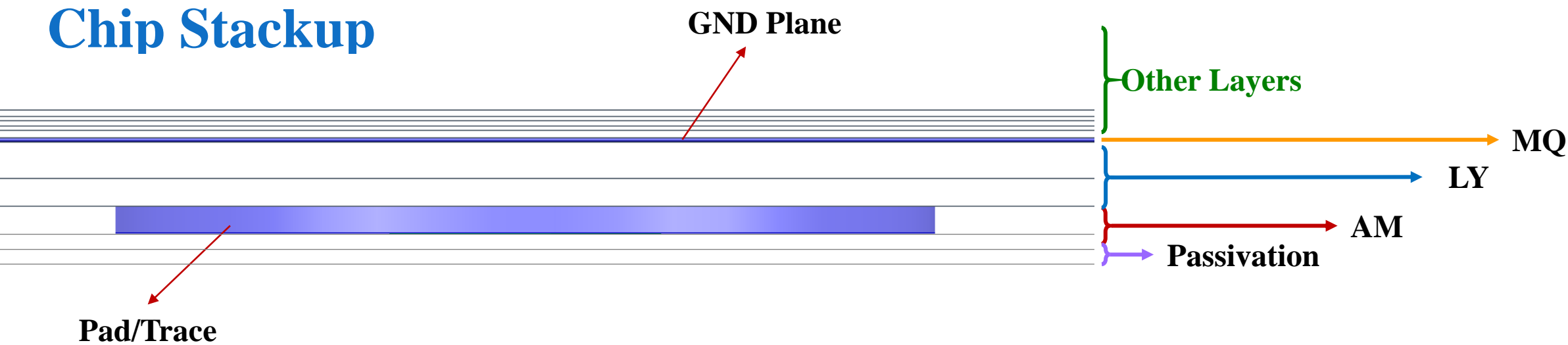
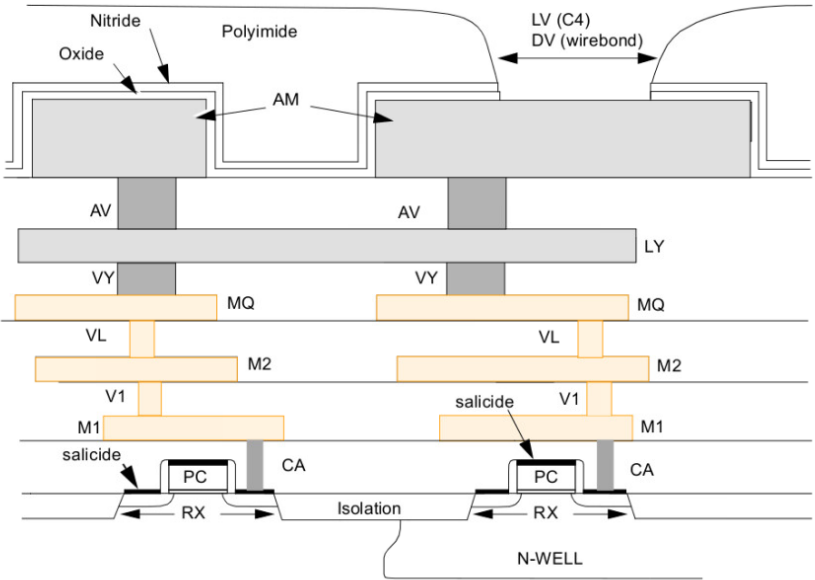


Figure 1-1. Cross Section of the 5 Level of Metal BEOL Option (2 Thin Mx; x=1,2 and 1 Thick = MQ and Analog Metal = LY, AM) with either DV or LV Final Passivation (not drawn to scale.)

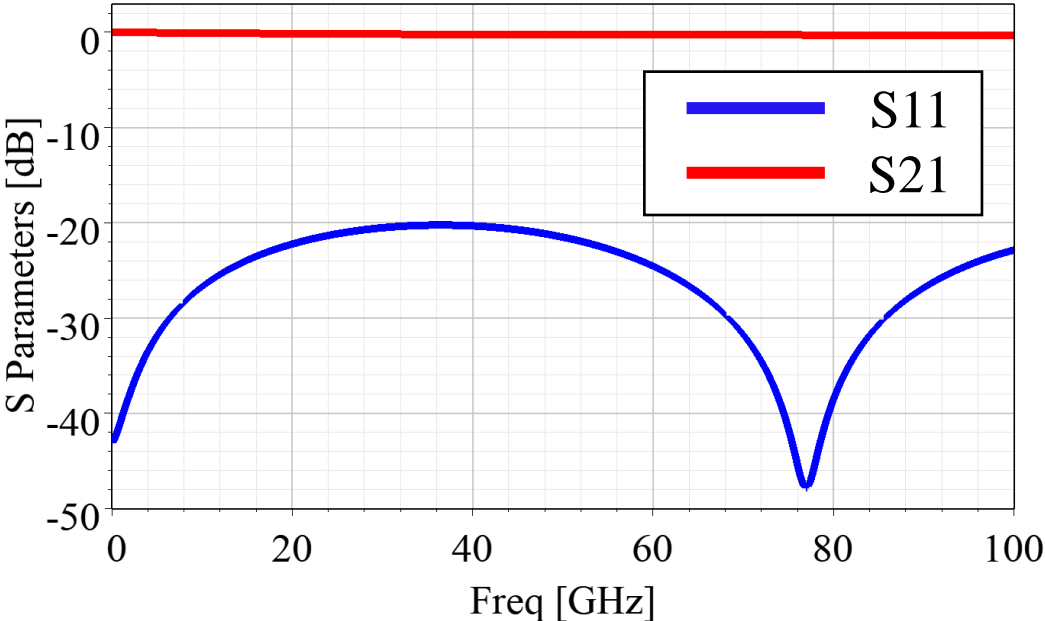
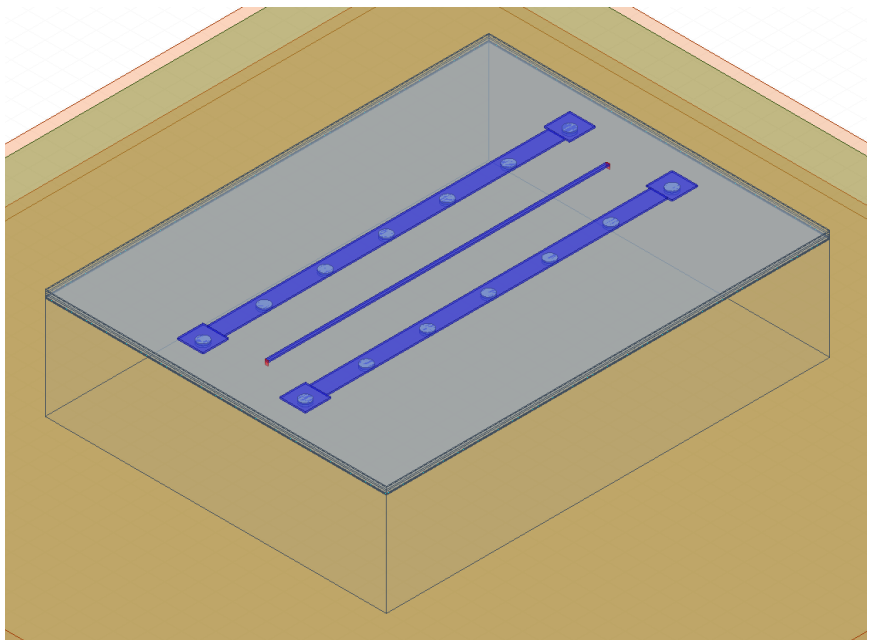


Redo	
0	AIR
1	
2	Polyimide (2.5 um)
3	
4	Nitride (0.45 um)
5	
6	SiO2_T (5.35 um)
7	123
8	SiO2_AV (4.0085 um)
9	119
10	SiO2_MM2 (0.029513 um)
11	86
12	SiO2_MM1 (0.061978 um)
13	
14	85
15	SiO2_VY (5.4 um)
16	79
17	SiO2_R (0.72 um)
18	114
19	SiO2_VL (1 um)
20	21
21	SiO2_V3 (0.7 um)
22	18
23	SiO2_V2 (0.7 um)
24	15
25	SiO2_V1 (0.67 um)
26	12
27	SiO2_B (0.95 um)
28	Silicon_Substrate (300 um)

Multiline TRL Method Options

Frequency Band	Recommended Solution	Line Lengths (mm)	Thru Line Length (mm)	Accuracy
20 to 100 GHz	One Line	0.617331	0.15	
20 to 150 GHz	One Line	0.435763	0.15	
10 to 100 GHz	Two Lines	0.5628, 1.779	0.15	
10 to 200 GHz	Two Lines	0.30271, 1.3537	0.15	

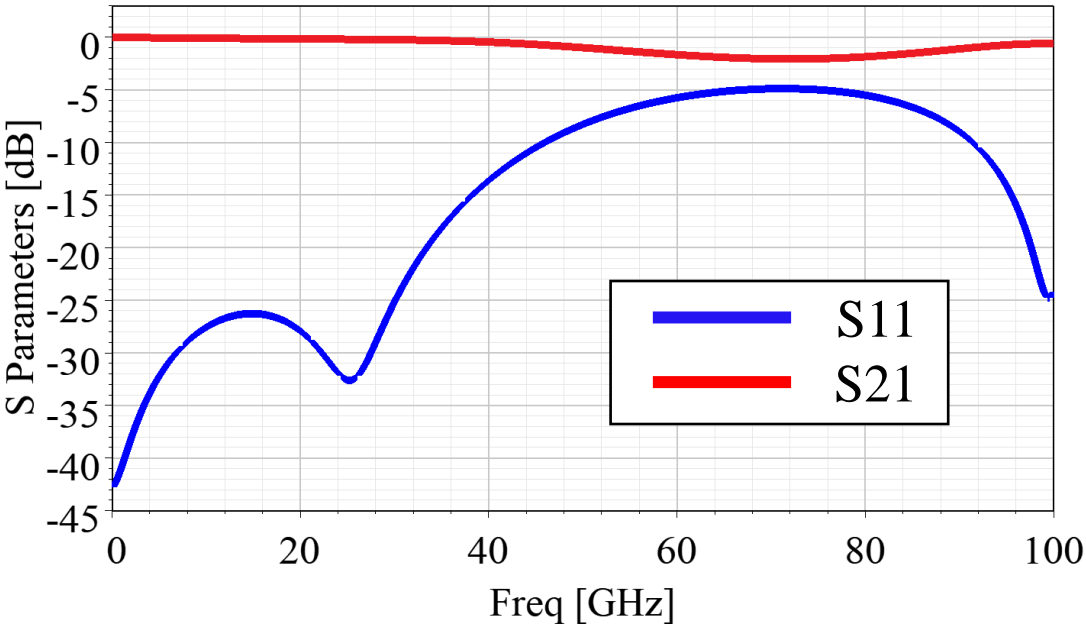
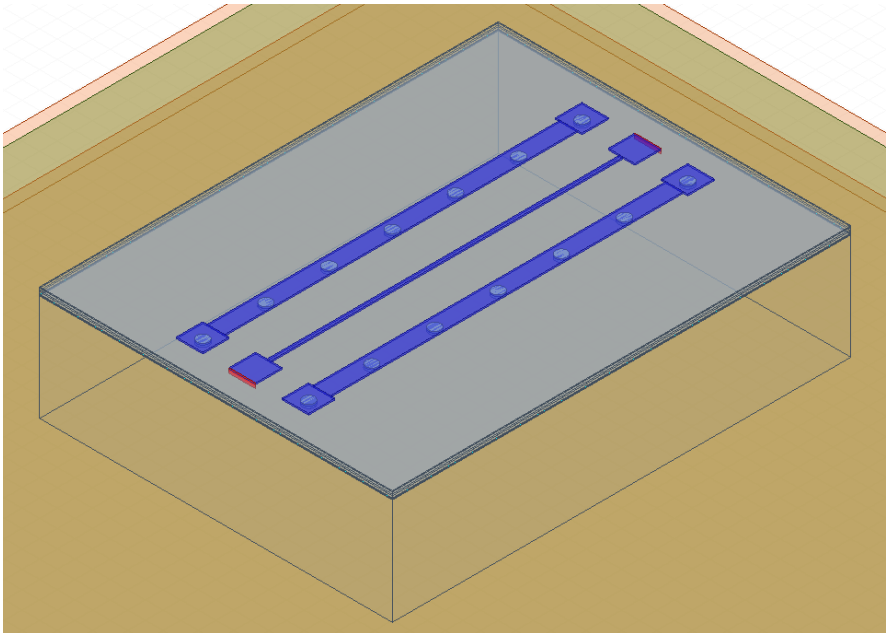
Trace (W=10um, L=1mm)



Multiline TRL Method Options

Frequency Band	Recommended Solution	Line Lengths (mm)	Thru Line Length (mm)	Accuracy
20 to 100 GHz	One Line	0.617331	0.15	
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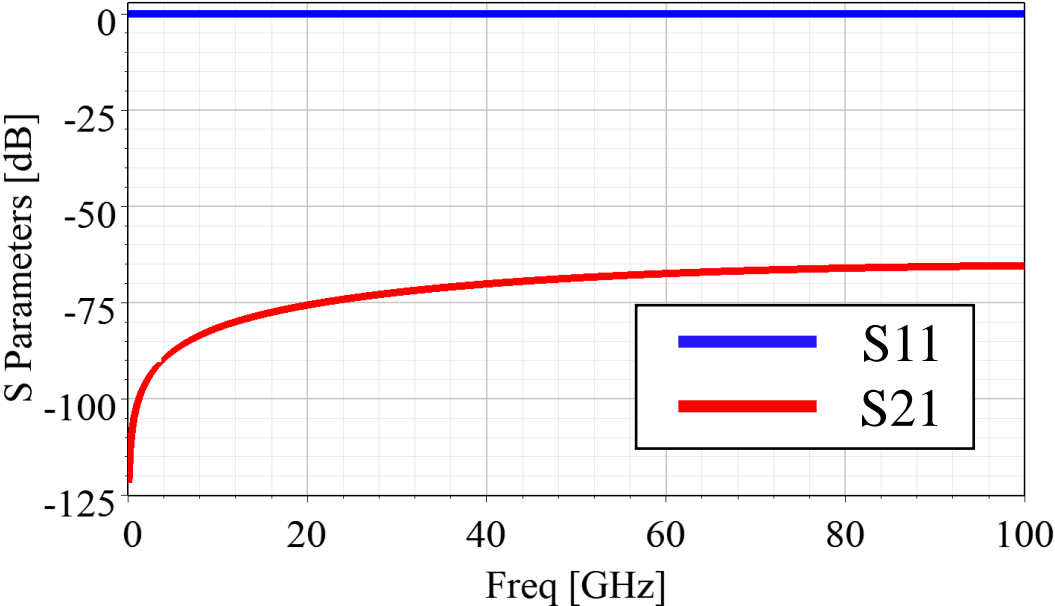
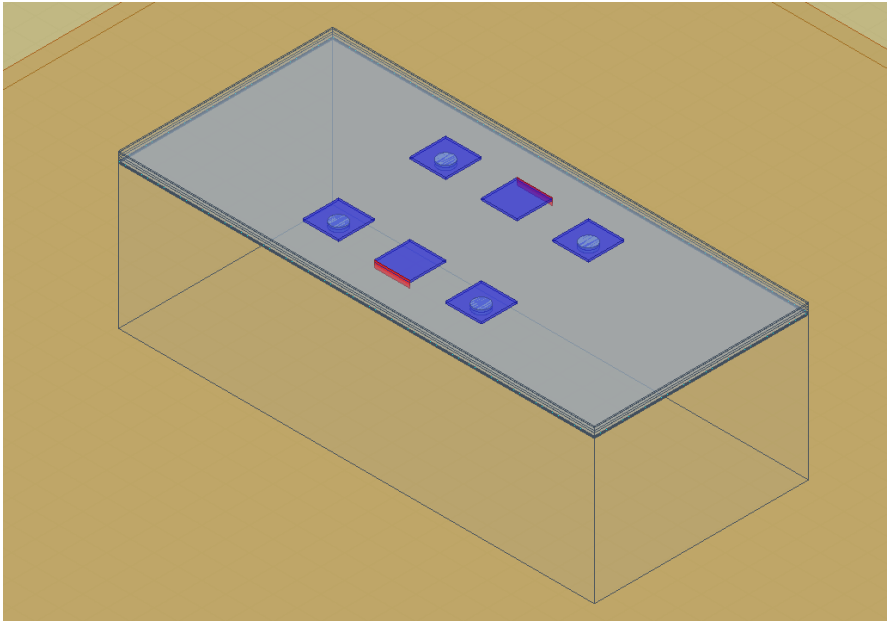
Trace (W=10um, L=1mm) + Pad (W=75um, L= 75um)



Multiline TRL Method Options

Frequency Band	Recommended Solution	Line Lengths (mm)	Thru Line Length (mm)	Accuracy
20 to 100 GHz	One Line	0.617331	0.15	
20 to 150 GHz	One Line	0.435763	0.15	
10 to 100 GHz	Two Lines	0.5628, 1.779	0.15	
10 to 200 GHz	Two Lines	0.30271, 1.3537	0.15	

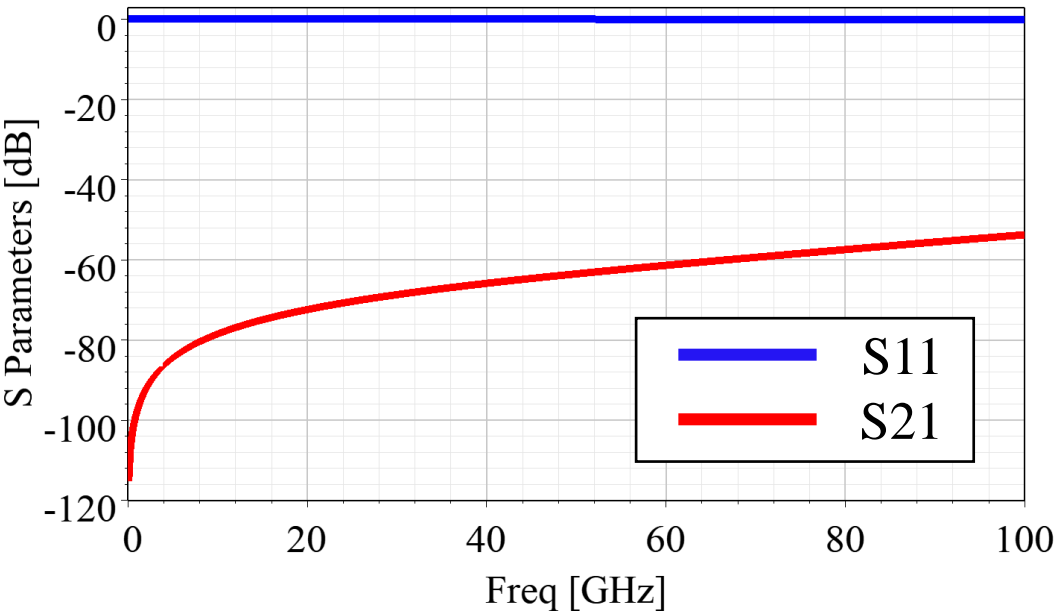
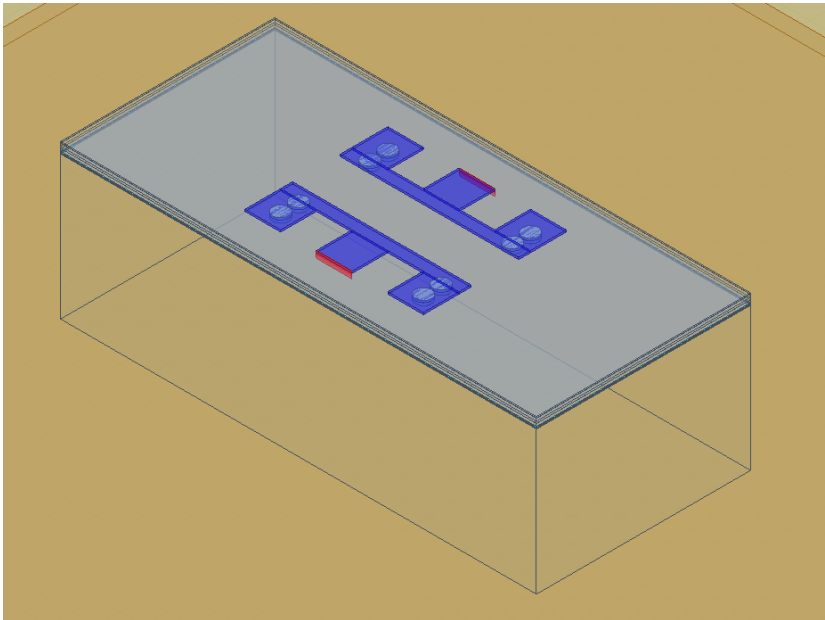
Open



Multiline TRL Method Options

Frequency Band	Recommended Solution	Line Lengths (mm)	Thru Line Length (mm)	Accuracy
20 to 100 GHz	One Line	0.617331	0.15	
20 to 150 GHz	One Line	0.435763	0.15	
10 to 100 GHz	Two Lines	0.5628, 1.779	0.15	
10 to 200 GHz	Two Lines	0.30271, 1.3537	0.15	

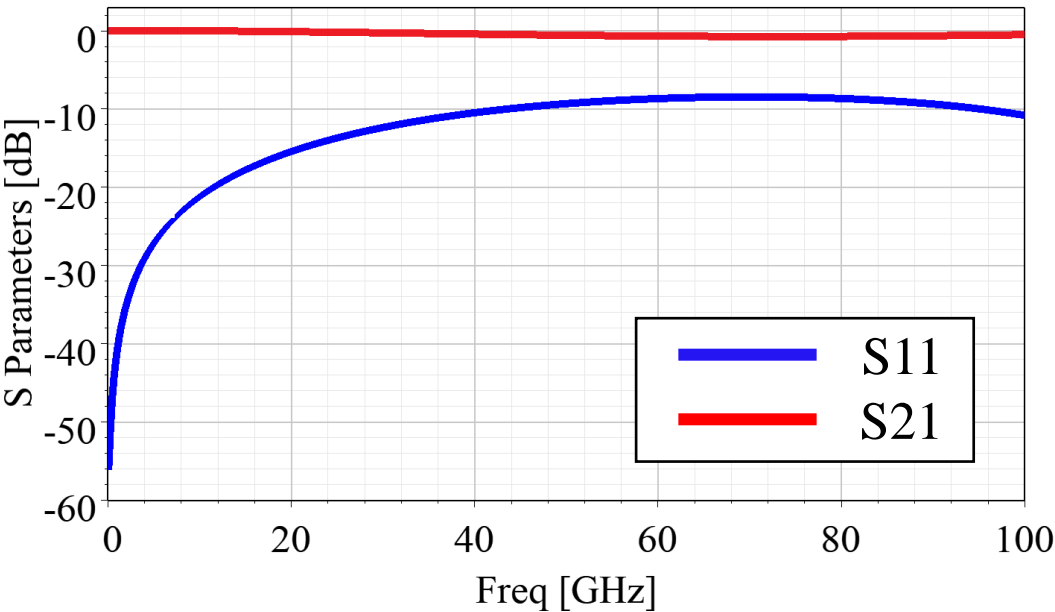
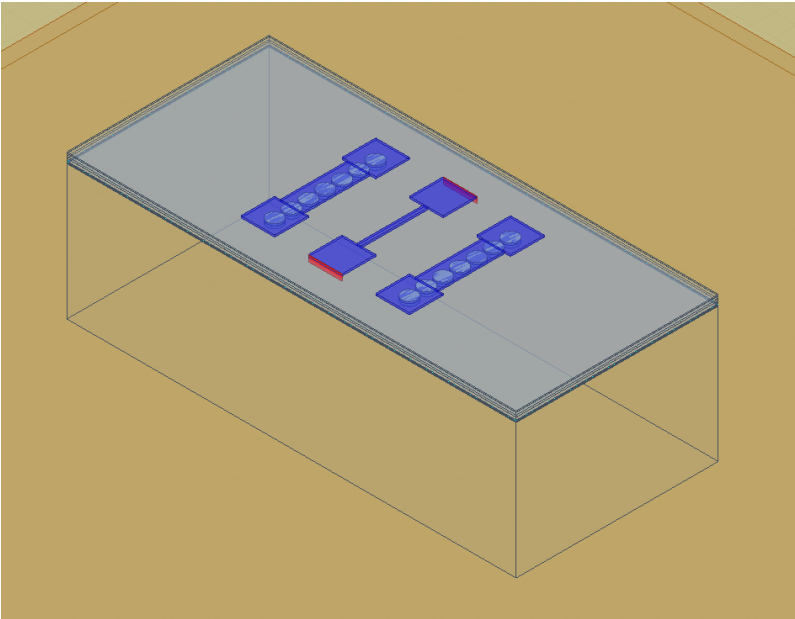
Short



Multiline TRL Method Options

Frequency Band	Recommended Solution	Line Lengths (mm)	Thru Line Length (mm)	Accuracy
20 to 100 GHz	One Line	0.617331	0.15	
20 to 150 GHz	One Line	0.435763	0.15	
10 to 100 GHz	Two Lines	0.5628, 1.779	0.15	
10 to 200 GHz	Two Lines	0.30271, 1.3537	0.15	

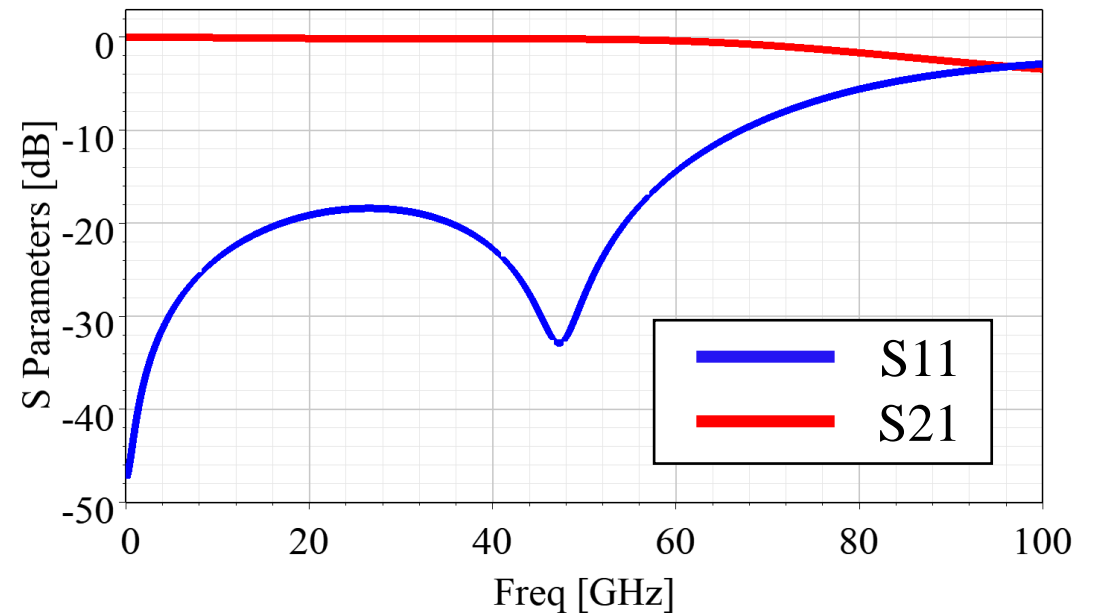
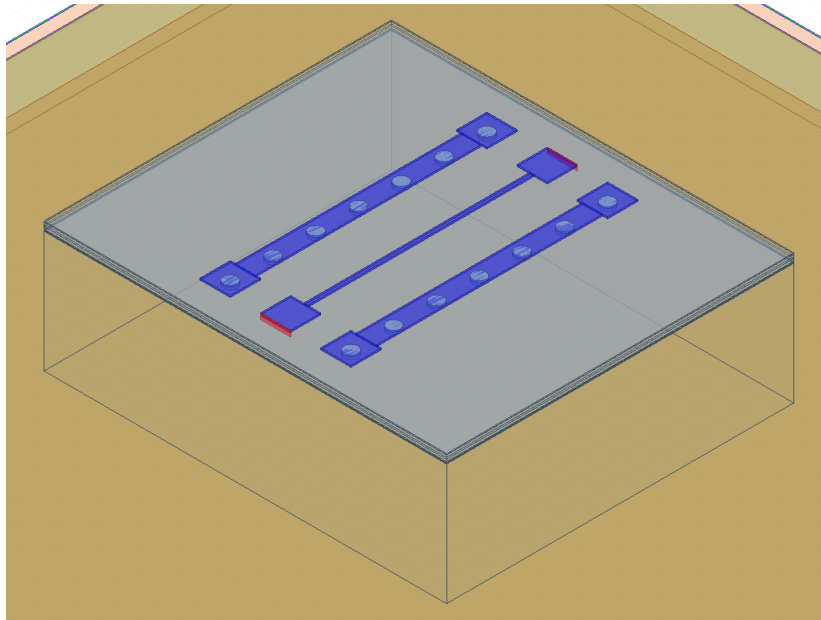
Thru



Multiline TRL Method Options

Frequency Band	Recommended Solution	Line Lengths (mm)	Thru Line Length (mm)	Accuracy
20 to 100 GHz	One Line	0.617331	0.15	
20 to 150 GHz	One Line	0.435763	0.15	
10 to 100 GHz	Two Lines	0.5628, 1.779	0.15	
10 to 200 GHz	Two Lines	0.30271, 1.3537	0.15	

Line 1 = 0.5628 mm



Multiline TRL Method Options

Frequency Band	Recommended Solution	Line Lengths (mm)	Thru Line Length (mm)	Accuracy
20 to 100 GHz	One Line	0.617331	0.15	
20 to 150 GHz	One Line	0.435763	0.15	
10 to 100 GHz	Two Lines	0.5628, 1.779	0.15	
10 to 200 GHz	Two Lines	0.30271, 1.3537	0.15	

Line 2 = 1.779 mm

